TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VHC4051AF,TC74VHC4051AFT,TC74VHC4051AFK TC74VHC4052AF,TC74VHC4052AFT,TC74VHC4052AFK TC74VHC4053AF,TC74VHC4053AFT,TC74VHC4053AFK

TC74VHC4051AF/AFT/AFK

8-Channel Analog Multiplexer/Demultiplexer TC74VHC4052AF/AFT/AFK

Dual 4-Channel Analog Multiplexer/Demultiplexer TC74V4053AF/AFT/AFK

Triple 2-Channel Analog Multiplexer/Demultiplexer

The TC74VHC4051A/4052A/4053A are high-speed, low-voltage drive analog multiplexer/demultiplexers using silicon gate CMOS technology. In 3 V and 5 V systems these can achieve high-speed operation with the low power dissipation that is a feature of CMOS.

The TC74VHC4051A/4052A/4053A offer analog/digital signal selection as well as mixed signals. The 4051A has an 8-channel configuration, the 4052A has an 4-channel \times 2 configuration, and the 4053A has a 2-channel \times 3 configuration.

The switches for each channel are turned ON by the control pin digital signals.

All control inputs are equipped with a newly developed input protection circuit that avoids the need for a diode on the plus side (forward side from the input to the VCC). As a result, for example, $5.5~\rm V$ signals can be permitted on the inputs even when the power supply voltage to the circuits is off. As a result of this input power protection, the TC74VHC4051A/4052A/4053A can be used in a variety of applications, including in the system which has two power supplies, and in battery backup circuits.

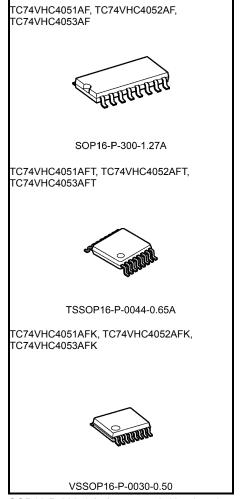
Features

- Low ON resistance: $R_{on} = 45\Omega$ (typ.) (V_{CC} = 3 V)
 - $R_{on} = 24\Omega$ (typ.) (VCC = 4.5 V)
- Input level: $V_{IL} = 0.8V \text{ (max)} (V_{CC} = 3 \text{ V})$

 $V_{IH} = 2.0V \text{ (min) } (V_{CC} = 3 \text{ V})$

Low power dissipation: $ICC = 2.0 \mu A \text{ (max) (Ta} = 25^{\circ}C)$

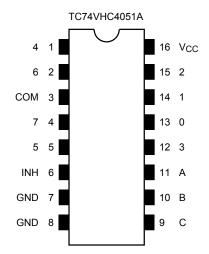
Power down protection is provided on all control inputs

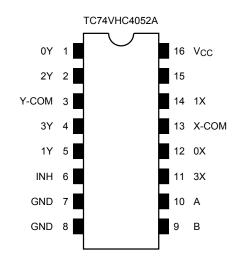


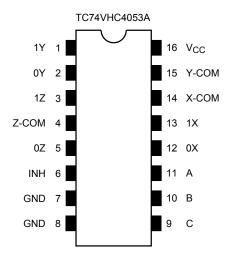
SOP16-P-300-1.27A : 0.18 g (typ.) TSSOP16-P-0044-0.65A : 0.06 g (typ.) VSSOP16-P-0030-0.50 : 0.02 g (typ.)



Pin Assignment (top view)







Truth Table

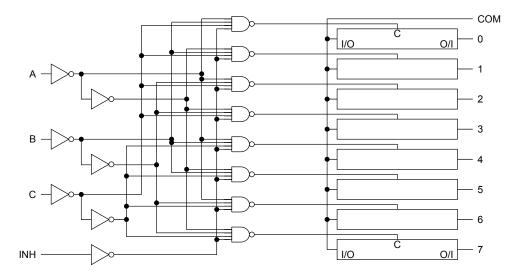
	Contro	Inputs		"ON" Channel				
Inhibit	C*	В	А	VHC4051A	VHC4053A			
L	L	L	L	0	0X, 0Y	0X, 0Y, 0Z		
L	L	L	Н	1	1X, 1Y	1X, 0Y, 0Z		
L	L	Н	L	2	2X, 2Y	0X, 1Y, 0Z		
L	L	Н	Н	3	3X, 3Y	1X, 1Y, 0Z		
L	Н	L	L	4	_	0X, 0Y, 1Z		
L	Н	L	Н	5	— 1X, 0Y			
L	Н	Н	L	6	_	0X, 1Y, 1Z		
L	Н	Н	Н	7	_	1X, 1Y, 1Z		
Н	Х	Х	Х	None	None	None		

X: Don't care, *: Except VHC4052A

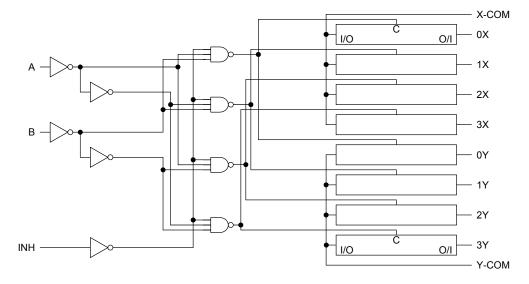


System Diagram

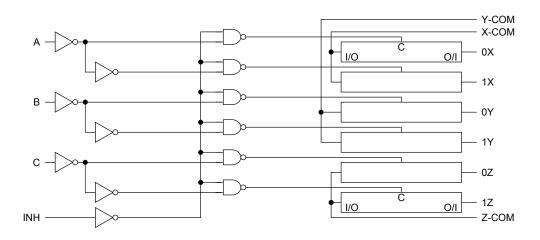
TC74VHC4051A



TC74VHC4052A



TC74VHC4053A





Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
Power supply voltage	V _{CC}	−0.5 to 7.0	V
Control input voltage	V _{IN}	−0.5 to 7.0	V
Switch I/O voltage	V _{I/O}	- 0.5 to V _{CC} + 0.5	V
Input diode current	I _{IK}	-20	mA
I/O diode current	l _{IOK}	±25	mA
Switch through current	I _T	±25	mA
DC V _{CC} or ground current	Icc	±50	mA
Power dissipation	P _D	180	mW
Storage temperature	T _{stg}	-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, may lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Operating Range (Note)

Characteristics	Symbol	Rating	Unit	
Power supply voltage	V _{CC}	2 to 5.5	V	
Input voltage	V _{IN}	0 to 5.5	V	
Switch I/O voltage	V _{I/O}	0 to V _{CC}	V	
Operating temperature	T _{opr}	-40 to 85	°C	
		0 to 200 (V _{CC} = $2.5 \pm 0.2 \text{ V}$)		
Input rise and fall time	dt/dv	0 to 100 ($V_{CC} = 3.3 \pm 0.3 \text{ V}$)	ns/V	
		0 to 20 ($V_{CC} = 5 \pm 0.5 \text{ V}$)		

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused control inputs must be tied to either V_{CC} or GND.



Electrical Characteristics

DC Electrical Characteristics

Characteristics S		Symbol	Test Condition		Ta = 25°C			Ta = -40	Unit	
		Syllibol	rest Condition	V _{CC} (V)	Min	Тур.	Max	Min	Max	Offic
				2.0	1.5	_	_	1.5	_	
	High-level	V _{IH}	_	3.0	2.0	_		2.0	_	v
	riigii-ievei			4.5	3.15	_		3.15	_	
Input voltage				5.5	3.85	_	_	3.85	_	
input voitage				2.0	_	_	0.5	_	0.5	V
	Low-level	١/		3.0	_	_	0.8	_	0.8	
	Low-level	V_{IL}	_	4.5	_	_	1.35	_	1.35	
				5.5	_	_	1.65	_	1.65	
			V _{IN} = V _{IL} or V _{IH}	2.3	_	200	_	_	_	Ω
		R _{ON}	$V_{I/O} = V_{CC}$ to GND	3.0	_	45	86	_	108	
ON resistance			$I_{I/O} = 2 \text{ mA}$	4.5	_	24	37	_	46	
ON resistance			V _{IN} = V _{IL} or V _{IH}	2.3	_	28	73		84	
			$V_{I/O} = V_{CC}$ or GND	3.0	_	22	38	_	44	
			$I_{I/O} = 2 \text{ mA}$	4.5	_	17	27	_	31	
Difference of O	N		V _{IN} = V _{IL} or V _{IH}	2.3	_	10	25		35	
resistance betw		ΔR _{ON}	$V_{I/O} = V_{CC}$ to GND	3.0	_	5	15	_	20	Ω
switches			$I_{I/O} = 2 \text{ mA}$	4.5	_	5	13	_	18	
Input/Output lea	akane		V _{OS} = V _{CC} or GND							
current	current		$V_{IS} = GND$ to V_{CC}	5.5	.5 —	_ _	±0.1	_	±1.0	μА
(switch OFF)			V _{IN} = V _{IL} or V _{IH}							
Input/Output leakage current (switch ON, output open)		I _{I/O}	$V_{OS} = V_{CC}$ or GND $V_{IN} = V_{IL}$ or V_{IH}	5.5	_		±0.1	_	±1.0	μΑ
Control input cu	urrent	I _{IN}	V _{IN} = V _{CC} or GND	5.5	_	_	±0.1	_	±1.0	μА
Quiescent supp	oly current	Icc	V _{IN} = V _{CC} or GND	5.5	_	_	2.0	_	20.0	μА



AC Electrical Characteristics (Input: $t_r = t_f = 3 \text{ ns}$)

Characteristics	Cumbal	Test Condition			Ta = 25°C)	Ta = -40 to 85°C		Unit	
Characteristics	Symbol			V _{CC} (V)	Min	Тур.	Max	Min	Max	Offic	
				2.5±0.2	_	1.2	10	_	16		
		$C_L = 15 p$ $R_L = 1 k\Omega$	F !		3.3±0.3	_	8.0	6	_	10	ns
Phase difference	φΙ/Ο			5.0±0.5	_	0.3	4	_	7		
between input and output	φί/Ο	$C_L = 50 \text{ pF}$ $R_L = 1 \text{ k}\Omega$		2.5±0.2	_	2.6	12	_	18		
				3.3±0.3		1.5	9	_	12		
				5.0±0.5	_	0.6	6	_	8		
				Figure 1	2.5±0.2	_	3.3	15	_	20	
		$C_L = 15 p$ $R_L = 1 k\Omega$	F !	Figure 1	3.3±0.3	_	2.3	11	_	15	ns
Output anable time	t _{pZL}				5.0±0.5	_	1.6	7	_	10	
Output enable time	tpZH			Figure 1	2.5±0.2	_	4.2	25	_	32	
		$C_L = 50 \text{ p}$ $R_I = 1 \text{ k}\Omega$	F 2	Figure 1	3.3±0.3	_	3.0	18	_	22	
					5.0±0.5	_	2.1	12	_	16	
	t _{pLZ} t _{pHZ}	$C_L = 15 \text{ pF}$ $R_L = 1 \text{ k}\Omega$		Figure 1	2.5±0.2	_	6	15	_	23	ns
					3.3±0.3	_	4.5	11	_	15	
Output disable time					5.0±0.5	_	3.2	7	_	10	
Output disable time				Figure 1	2.5±0.2	_	9.6	25	_	32	
		$C_L = 50 \text{ pF}$ $R_L = 1 \text{ k}\Omega$	3.3±0.3		_	7.2	18	_	22		
					5.0±0.5	_	5.1	12	_	16	
Control input capacitance	C _{IN}	All types			_		3	_	_	10	pF
		4051A					23.4				
COMMON terminal capacitance	C _{IS}	4052A	Figur	e 2	_	_	13.1	_	_	_	pF
		4053A					8.2				
		4051A	į	•		_	5.7				
SWITCH terminal capacitance	Cos	4052A	Figur	e 2	_		5.6	_	_	_	pF
Sapasitarios		4053A					5.6				
		4051A					0.5				
Feedthrough capacitance	C _{IOS}	4052A	Figure 2		_	_	0.5	_	_	_	pF
		4053A					0.5				
		4051A	Figure 2 (Note)				15		_	_	pF
Power dissipation capacitance	C _{PD}	4052A			_	_	24	1 —			
Sapasitarios		4053A					12				

Note: CPD is defined as the value of the internal equivalent capacitance of IC which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

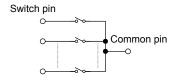
 $I_{CC \text{ (opr)}} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$



Analog Switch Characteristics (Ta = 25°C) (Note)

Characteristics	Test Condition			Тур.	Unit
onarastonous s	7551 55114181511	V _{CC} (V)	. , , ,		
Sine Wave Distortion (T.H.D)	$R_L = 10 \text{ k}\Omega$, $C_L = 50 \text{ pF}$,	$V_{IN}=2.0\;V_{p\text{-}p}$	3.0	0.1	%
Office wave distortion (1.11.b)	f _{IN} = 1 kHz	$V_{IN} = 4.0 \ V_{p\text{-}p}$	4.5	0.03	70
	V _{IN} is centered at (V _{CC} /2).	4051A		150	
	Adjust input for 0dBm.	4052A	3.0	200	
Frequency response	Increase f _{IN} frequency until dB meter	4053A		240	MHz
(switch ON)	reads –3dB.	4051A		180	
	$R_L = 50 \ \Omega, \ C_L = 10 \ pF, sine wave$	4052A	4.5	230	
	Figure 3	4053A		280	
	V _{IN} is centered at (V _{CC} /2). Adjust input for 0dBm.	3.0	-45	dB	
Feed through attenuation (switch OFF)	$R_L = 600 \ \Omega, \ C_L = 50 \ pF, \ f_{IN} = 1 \ MHz, \ s$ Figure 4	4.5	-45		
	$R_{I} = 50 \Omega$, $C_{I} = 10 pF$, $f_{IN} = 1 MHz$, sin	3.0	-65		
		4.5	-65		
Crosstalk	$R_L = 600 \Omega$, $C_L = 50 pF$, $f_{IN} = 1 MHz$, s	3.0	60	mV	
(control input to signal output)	$(t_r = t_f = 6 \text{ ns})$ Figure 5	4.5	100	IIIV	
Crosstalk	V _{IN} is centered at (V _{CC} /2). Adjust inpu	3.0	-45		
(between any switches)	$R_L = 600~\Omega,~C_L = 50~pF,~f_{IN} = 1~MHz,~sine~wave$ Figure 6			-45	dB

Note: These characteristics are determined by design of devices.



AC Test Circuit

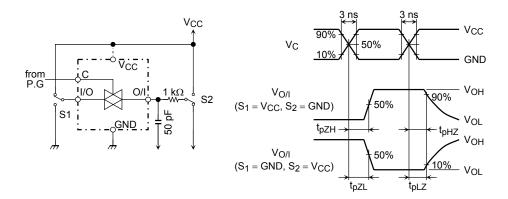


Figure 1 t_{pLZ} , t_{pHZ} , t_{pZL} , t_{pZH}

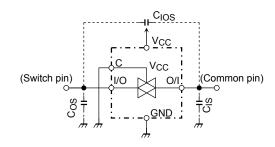


Figure 2 C_{IOS}, C_{IS}, C_{OS}

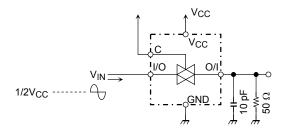


Figure 3 Frequency Response (switch on)

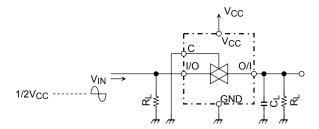


Figure 4 Feedthrough

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Figure 5 Cross Talk (control input to output signal)

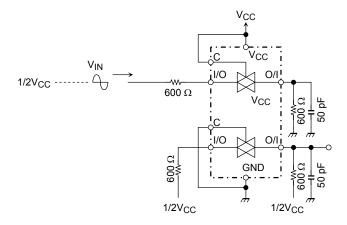
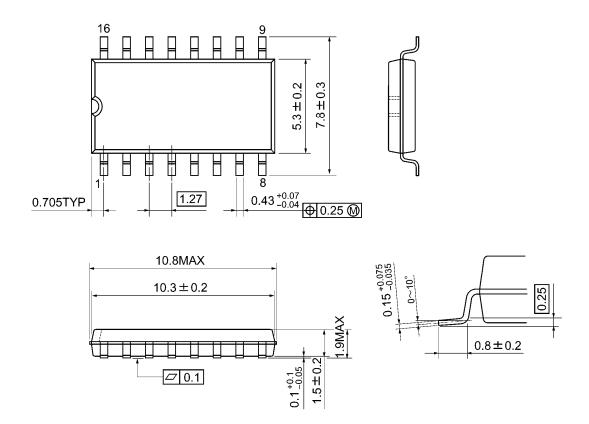


Figure 6 Cross Talk (between any two switches)



Package Dimensions

SOP16-P-300-1.27A Unit: mm



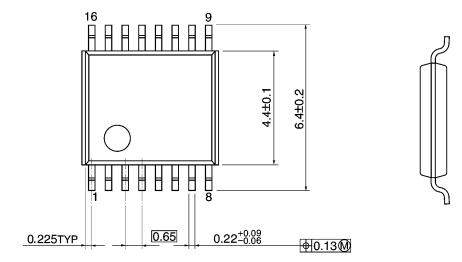
Weight: 0.18 g (typ.)

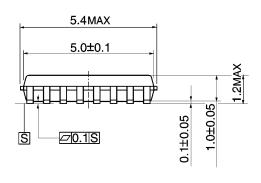


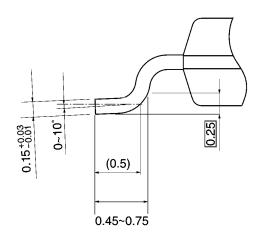
Package Dimensions

TSSOP16-P-0044-0.65A

Unit: mm



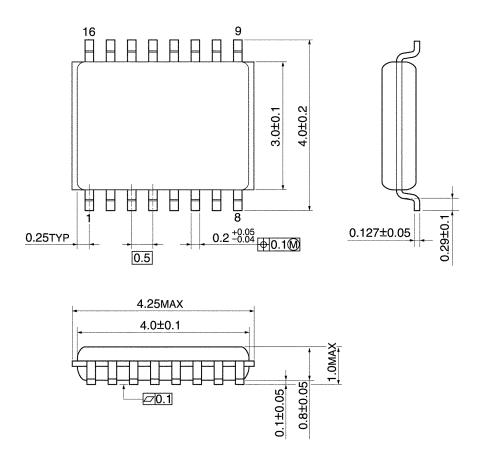




Weight: 0.06 g (typ.)

Package Dimensions

VSSOP16-P-0030-0.50 Unit: mm



Weight: 0.02 g (typ.)

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20070701-EN GENERAL

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